

High Voltage Silicon Pin Diode

These devices are designed primarily for VHF band switching applications but are also suitable for use in general–purpose switching circuits. They are supplied in a cost–effective plastic surface mount package for economical, high–volume consumer and industrial requirements.

- Long Reverse Recovery Time trr = 300 ns (Typ)
- Rugged PIN Structure Coupled with Wirebond Construction for Optimum Reliability
- Low Series Resistance @ 100 MHz R_S = 0.7 Ω (Typ) @ I_F = 10 mAdc
- Reverse Breakdown Voltage = 200 V (Min)
- Device Marking: 4R

MMVL3700T1

SILICON PIN SWITCHING DIODE





ORDERING INFORMATION

Device	Package	Shipping
MMVL3700T1	SOD-323	3000 / Tape & Reel

MAXIMUM RATINGS

Symbol	Rating	Value	Unit	
V _R	Continuous Reverse Voltage	200	Vdc	
I _F	Peak Forward Current	20	mAdc	

THERMALCHARACTERISTICS

Symbol	Characteristic	Max	Unit
P_D	Total Device Dissipation FR-5 Board,*	200	mW
	$T_A = 25$ °C		
	Derate above 25°C	1.57	mW/°C
$R_{\theta JA}$	Thermal Resistance Junction to Ambient	635	°C/W
T_J, T_{stg}	Junction and Storage Temperature	150	℃

^{*}FR-4 Minimum Pad

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Тур	Max	Unit
Reverse BreakdownVoltage	$V_{(BR)R}$	200	_	_	Vdc
(I _R = 10 μAdc)					
Diode Capacitance	C_{\scriptscriptstyleT}	_	_	1.0	pF
(V _R = 20 Vdc, f = 1.0 MHz)					
Series Resistance	R_s	_	0.7	1.0	Ω
(I _F = 10 mAdc)					
Reverse Leakage Current	I _R	_	_	0.1	μAdc
(V _R = 150 Vdc)					
Reverse Recovery Time	t _{rr}	_	300	_	ns
$(I_F = I_R = 10 \text{ mAdc})$					



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TYPICAL CHARACTERISTICS

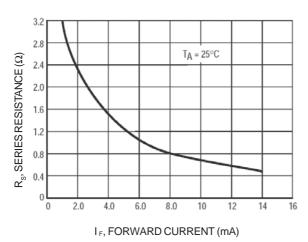


Figure 1. Series Resistance

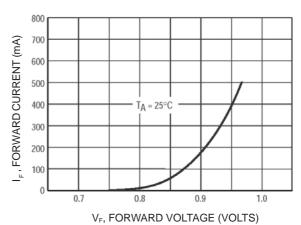


Figure 2. Forward Voltage

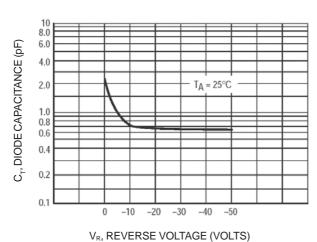
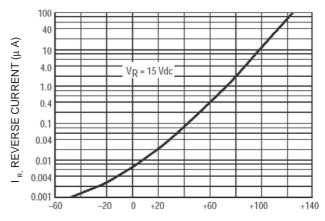


Figure 3. Diode Capacitance



T_A, AMBIENTTEMPERATURE (°C) **Figure 4. Leakage Current**